Search Notes

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Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/721,764	BEDARD ET AL.	
Examiner	Art Unit	
Dave Willse	3738	

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Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
searched examiner's collection of foreign patents	6/26/2006	DW
reviewed search results in parent 10/463,495	6/26/2006	DW
PLUS search	6/26/2006	DW